

Notice of References Cited	Application/Control No. 10/550,741	Applicant(s)/Patent Under Reexamination SURDEANU ET AL.	
	Examiner JOHN LIN	Art Unit 2815	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2001/0039107	11-2001	Suguro, Kyoichi	438/585
*	C	US-6,399,515	06-2002	Tao et al.	438/734
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	L	US-			
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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